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VDSSDrain to Source Voltage75VVGSGate to Source Voltage ± 20 VDrain CurrentDrain Current80AIDContinuous (T _C < 127°C, V _{GS} = 10V)80AContinuous (T _{amb} = 25°C, V _{GS} = 10V, with R _{0JA} = 43°C/W)16APulsedFigure 4AEASSingle Pulse Avalanche Energy (Note 1)350mJPDDerate above 25°C1.7W/°CTJ, TSTGOperating and Storage Temperature-55 to 175°CThermal CharacteristicsR _{0JC} Thermal Resistance Junction to Case, Max. TO-220, D²-PAK (Note 2)62°C/MR _{0JA} Thermal Resistance Junction to Ambient, Max. TO-220, D²-PAK (Note 2)62°C/M	N-Cha	60AN08A0 / FDB060AN08A0 nnel PowerTrench [®] MOSFET A, 6 m Ω			
 Q_{0(trol} = 73 nC (Typ.) @ V_{0S} = 10 V Low Q_{in} Body Diode UIS Capability (Single Pulse and Repetitive Pulse) Formerly developmental type 82880 Motor drives and Uninterruptible Power Supplies US Capability (Single Pulse and Repetitive Pulse) Formerly developmental type 82880 MOSFET Maximum Ratings T_C = 25°C unless otherwise noted Symbol Parameter FDP060AN08A0 Unit V_{OSS} Drain to Source Voltage 75 V V_{GS} Gate to Source Voltage 75 V V_{GS} Gate to Source Voltage 75 V Continuous (T_G + 127°C, V_{GS} = 10V) Continuous (T_G + 25°C, V_{GS} = 10V) Continuous (T_G + 127°C, V_{GS} = 10V) Continuous (T_G + 25°C, V_{GS} = 10V) Continuous (T_G + 25°C, V_{GS} = 10V) Continuous (T_G + 25°C, V_{GS} = 10V, with R_{0,IA} = 43°C/W) A Fugure 4 A E_{AS} Single Pulse Avalanche Energy (Note 1) Single Pulse Avalanche Energy (Note 1) Conternet - 55 to 175 °C Thermal Resistance Junction to Case, Max. TO-220, D²-PAK (Note 2) Ci Thermal Resistance Junction to Ambient, Max. TO-220, D²-PAK (Note 2) Ci Thermal Resistance Junction to Ambient, Max. TO-220, D²-PAK (Note 2) Ci Conton Conton Ambient, Max. TO-220, D²-PAK (Note 2) 	Features	Applications			
$\label{eq:constraint} \begin{split} & \overbrace{D_{C}}^{O} \overbrace{D_{C}}^{O} \overbrace{D_{C}}^{O} O_{C} O_{C}$	 R_{DS(on)} = 2 Q_{G(tot)} = 7 Low Mille Low Q_{rr} B UIS Capa 	$4.8 \text{ m}\Omega (\text{Typ.}) \textcircled{0} V_{GS} = 10 \text{ V}, I_D = 80 \text{ A}$ • Synchronous Rectifi $3 \text{ nC} (\text{Typ.}) \textcircled{0} V_{GS} = 10 \text{ V}$ • Battery Protection Cit $3 \text{ nC} (\text{Typ.}) \textcircled{0} V_{GS} = 10 \text{ V}$ • Motor drives and Un 10 cdy Diode • Motor Pulse)	rcuit		
SymbolParameterFDB060AN08A0Onto V_{DSS} Drain to Source Voltage75V V_{GS} Gate to Source Voltage ± 20 VDrain Current ± 20 V I_D Continuous ($T_C < 127^{\circ}C, V_{GS} = 10V$)80 I_D Continuous ($T_{amb} = 25^{\circ}C, V_{GS} = 10V$, with $R_{\theta,JA} = 43^{\circ}C/W$)16 I_D PulsedFigure 4 P_D Power dissipation255 P_D Derate above 25^{\circ}C1.7 T_{J}, T_{STG} Operating and Storage Temperature-55 to 175°CThermal Characteristics $R_{\theta,JC}$ Thermal Resistance Junction to Case, Max. TO-220, D ² -PAK (Note 2)62 O_{CM}	MOSFE	T Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted	GO-	s)
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Symbol	Parameter			Unit
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	V _{DSS}	Drain to Source Voltage		75	V
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	V _{GS}	Gate to Source Voltage		±20	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	I _D	Continuous ($T_C < 127^{\circ}C$, $V_{GS} = 10V$)		16	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $			Fi	-	
P _D Derate above 25°C 1.7 W/°C T _J , T _{STG} Operating and Storage Temperature -55 to 175 °C Thermal Characteristics R _{θJC} Thermal Resistance Junction to Case, Max. TO-220, D ² -PAK 0.58 °C/M R _{θJA} Thermal Resistance Junction to Ambient, Max. TO-220, D ² -PAK (Note 2) 62 °C/M	E _{AS}				
TJ, TSTG Operating and Storage Temperature -55 to 175 °C Thermal Characteristics ReJC Thermal Resistance Junction to Case, Max. TO-220, D²-PAK 0.58 °C/M ReJA Thermal Resistance Junction to Ambient, Max. TO-220, D²-PAK (Note 2) 62 °C/M	PD				
Thermal Characteristics R _{θJC} Thermal Resistance Junction to Case, Max. TO-220, D ² -PAK 0.58 °C/M R _{θJA} Thermal Resistance Junction to Ambient, Max. TO-220, D ² -PAK (Note 2) 62 °C/M	T. Toro		-55		
$R_{\theta JA}$ Thermal Resistance Junction to Ambient, Max. TO-220, D ² -PAK (Note 2) 62 °C/M					
$R_{\theta JA}$ Thermal Resistance Junction to Ambient, Max. TO-220, D ² -PAK (Note 2) 62 °C/M	Raic	Thermal Resistance Junction to Case, Max. TO-220, D ² -PAK		0.58	°C/W
			ote 2)		°C/W
Rein I I hermal Resistance Junction to Ambient, Max. D ² -PAK. 1in ² copper bad area I 43 I °CM	R _{0JA}	Thermal Resistance Junction to Ambient, Max. D ² -PAK, 1in ² copper		43	°C/W

Symbol	Parameter	FDP060AN08A0 FDB060AN08A0	Unit V	
V _{DSS}	Drain to Source Voltage	75		
V _{GS}	Gate to Source Voltage	±20	V	
	Drain Current			
	Continuous ($T_C < 127^{\circ}C$, $V_{GS} = 10V$)	80	Α	
ID	Continuous (T_{amb} = 25°C, V_{GS} = 10V, with $R_{\theta JA}$ = 43°C/W)	16	Α	
	Pulsed	Figure 4	Α	
E _{AS}	Single Pulse Avalanche Energy (Note 1)	350	mJ	
P _D	Power dissipation	255	W	
	Derate above 25°C	1.7	W/°C	
T _J , T _{STG}	Operating and Storage Temperature	-55 to 175	°C	

1

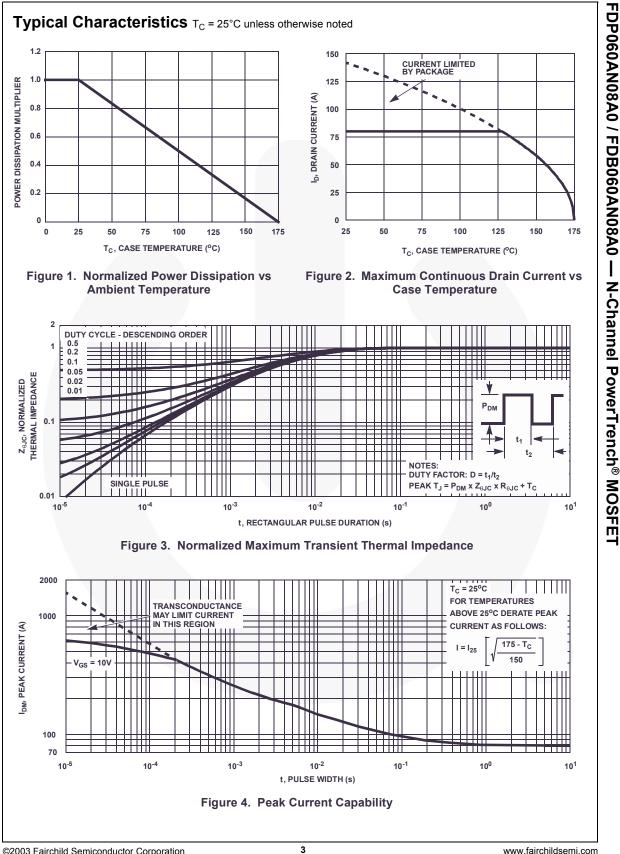
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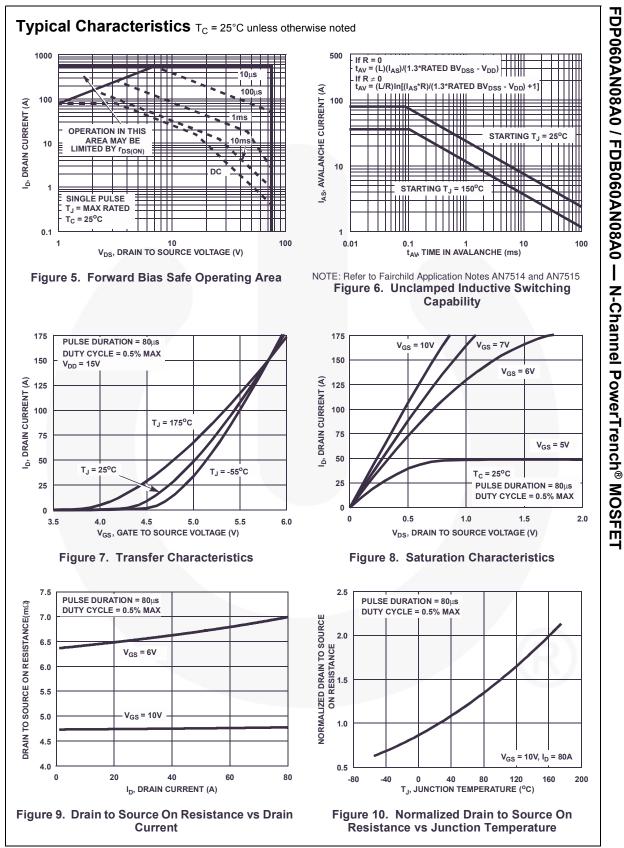
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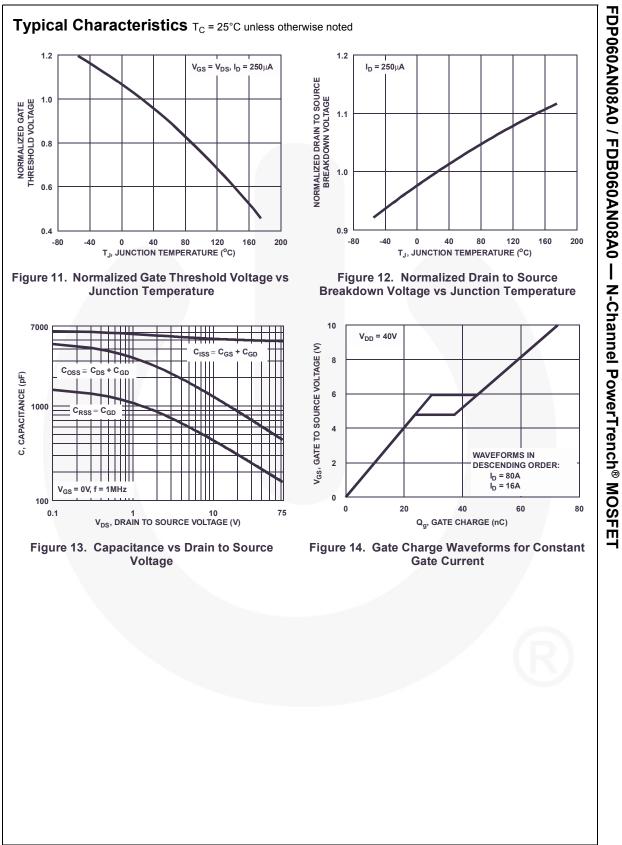
Device Marking FDB060AN08A0		Device	Package		Tape \	Vidth	Quantity	
		FDB060AN08A0	D ² -PAK		24 mm		800 units	
	DAN08A0	FDP060AN08A0	TO-220	Tube	N/	A	50 u	nits
Electric Symbol		Acteristics T _C = 25°C Parameter		e noted	Min	Тур	Мах	Unit
	!		1031 0	Jonations	WIIII	Typ	Max	Unit
Off Char	acteristic	S						
B _{VDSS}	Drain to S	ource Breakdown Voltage	I _D = 250μA, V	_{GS} = 0V	75	-	-	V
I _{DSS}	Zero Gate	e Voltage Drain Current	urrent $V_{DS} = 60V$ $V_{GS} = 0V$ $T_C = 150^{\circ}C$		-	-	1 250	μA
I _{GSS}	Gate to Source Leakage Current		V _{GS} = ±20V	0	-	-	±100	nA
					1	1	L	
	acteristic					1		
V _{GS(TH)}	Gate to S	ource Threshold Voltage	$V_{GS} = V_{DS}, I_{DS}$		2	-	4	V
			I _D = 80A, V _{GS}	; = 10V	-	0.0048	0.006	
r _{DS(ON)}	Drain to S	ource On Resistance	$I_D = 40A, V_{GS}$		-	0.0066	0.010	Ω
20(011)			I _D = 80A, V _{GS} T _J = 175°C	I _D = 80A, V _{GS} = 10V, T _J = 175°C		0.010	0.013	
Dynamic	: Characte	eristics						
C _{ISS}	Input Cap	acitance			-	5150	-	pF
C _{OSS}	Output Ca	apacitance	— V _{DS} = 25V, V — f = 1MHz	_{GS} = 0V,	-	800	-	pF
C _{RSS}	Reverse 1	ransfer Capacitance			-	230	-	pF
Q _{g(TOT)}	Total Gate	e Charge at 10V	V _{GS} = 0V to 1	0V		73	95	nC
Q _{g(TH)}	Threshold	Gate Charge		V V _{DD} = 40V	-	10	13	nC
Q _{gs}	Gate to S	ource Gate Charge		I _D = 80A	-	29	-	nC
Q _{gs2}	Gate Cha			I _g = 1.0mA	-	19	-	nC
Q _{gd}	Gate to D	rain "Miller" Charge			-	16	-	nC
Switchin	g Charac	teristics (V _{GS} = 10V)						
t _{ON}	Turn-On Time				-	-	147	ns
t _{d(ON)}	Turn-On E	Turn-On Delay Time			-	19	-	ns
t _r	Rise Time	9	V _{DD} = 40V, I _D	= 80A	-	79	-	ns
t _{d(OFF)}	Turn-Off E	Delay Time		$V_{GS} = 10V, R_{GS} = 3.9\Omega$		37	-	ns
t _f	Fall Time				-	38	-	ns
t _{OFF}	Turn-Off T	īme			-		113	ns
	ource Diod	de Characteristics					6	1
\/	Course to	Droin Diodo Maltara	I _{SD} = 80A		- /	-	1.25	V
V _{SD}	Source to Drain Diode Voltage		I _{SD} = 40A		-	-	1.0	V
1	Reverse F	Recovery Time		_{SD} /dt = 100A/µs	-	-	37	ns
t _{rr}	Deveneer	Recovered Charge	I _{SD} = 75A, dI _{SD} /dt = 100A/μs		-	-	38	nC

2

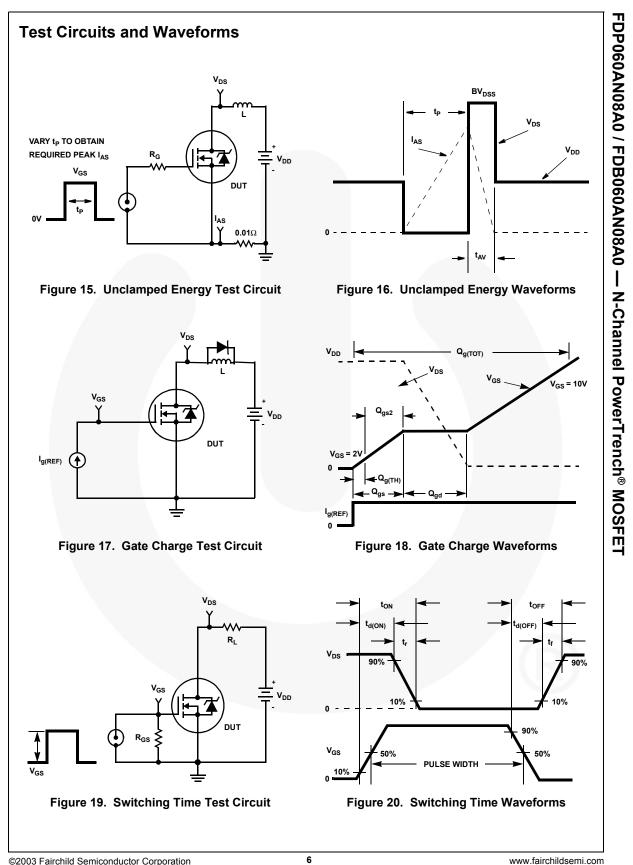




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Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature, T_{JM} , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation, P_{DM} , in an application. Therefore the application's ambient temperature, T_A (°C), and thermal resistance $R_{\theta JA}$ (°C/W) must be reviewed to ensure that T_{JM} is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$
(EQ. 1)

In using surface mount devices such as the TO-263 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of P_{DM} is complex and influenced by many factors:

- Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- 2. The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

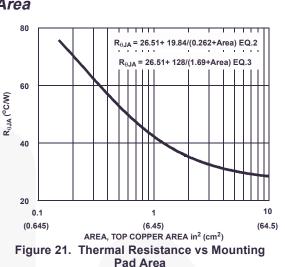
Fairchild provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the $R_{\theta,JA}$ for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the Fairchild device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeters square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

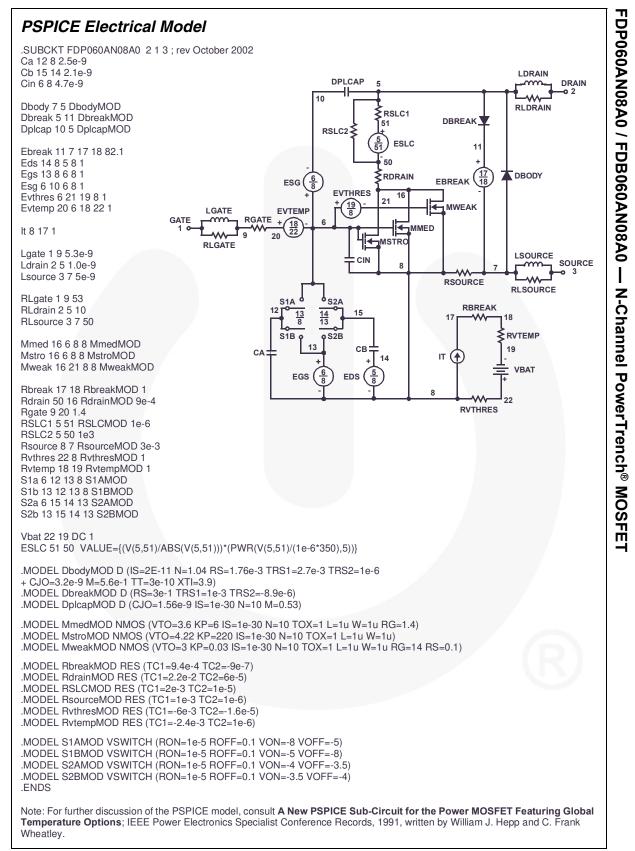
$$R_{\Theta JA} = 26.51 + \frac{19.84}{(0.262 + Area)}$$
(EQ. 2)

Area in Inches Squared

$$R_{\Theta JA} = 26.51 + \frac{128}{(1.69 + Area)}$$
(EQ. 3)
Area in Centimeters Squared



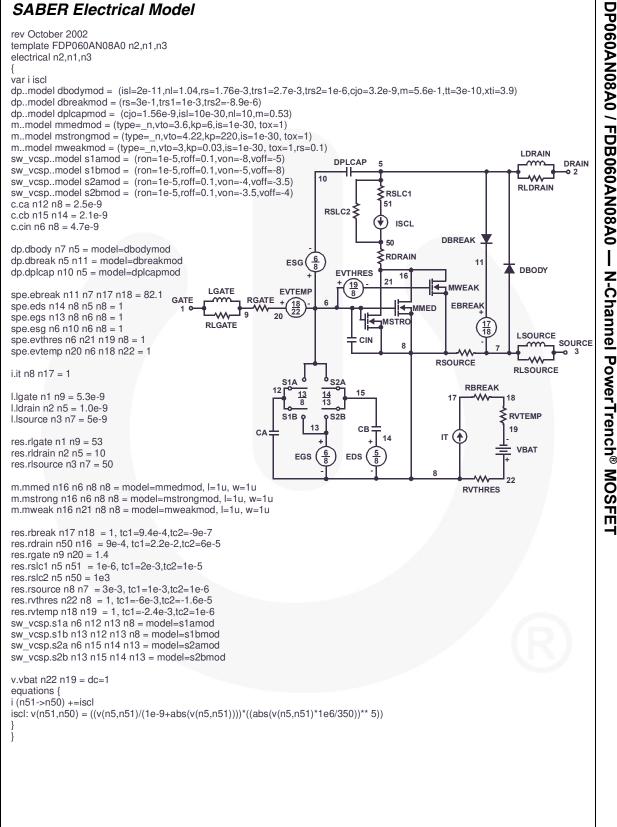
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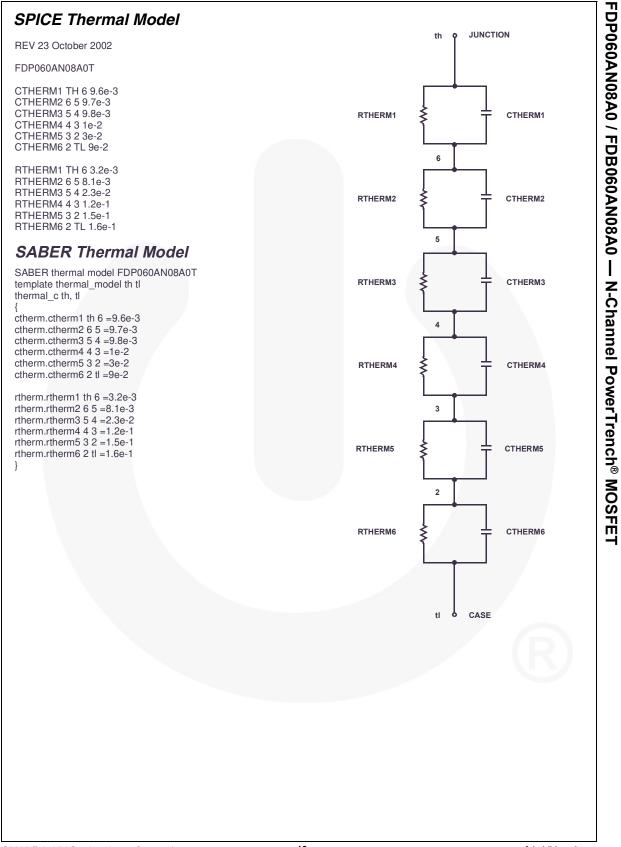


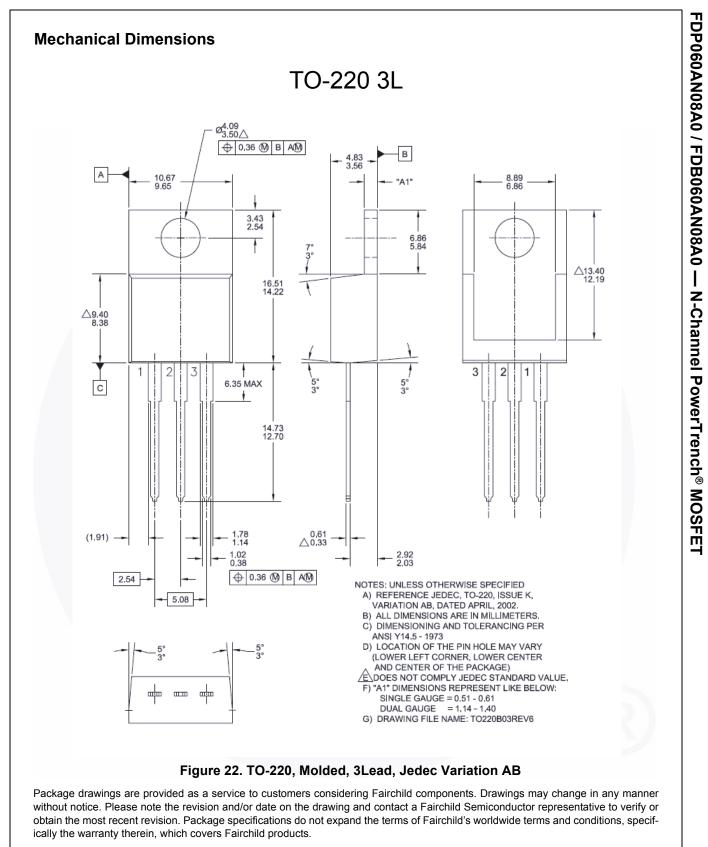
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SABER Electrical Model



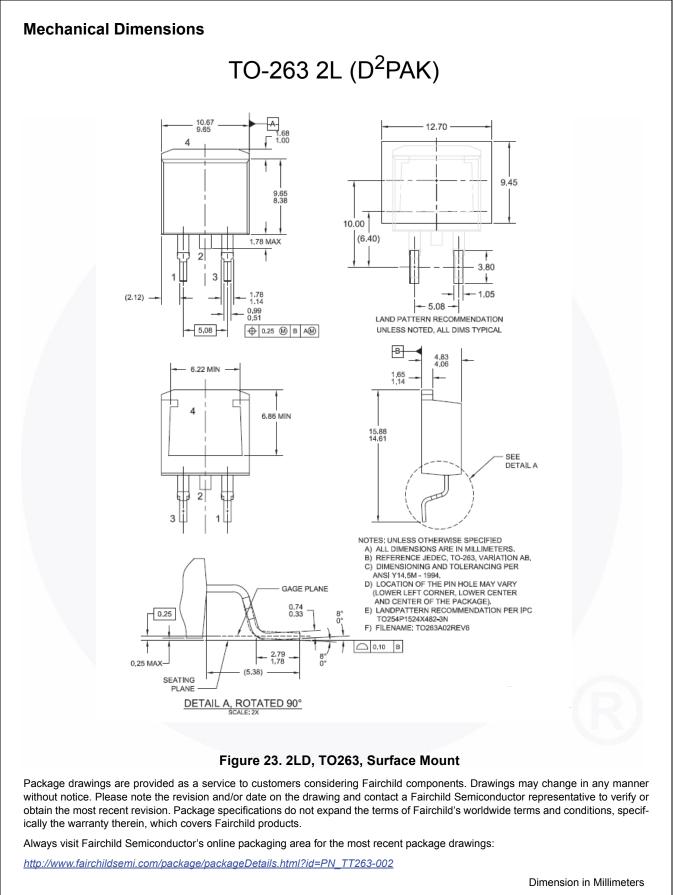




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http://www.fairchildsemi.com/package/packageDetails.html?id=PN_TT220-003

Dimension in Millimeters





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